

<b>Notice of References Cited</b>	Application/Control No. 10/670,728	Applicant(s)/Patent Under Reexamination INABA ET AL.	
	Examiner Meghan K. Dunwiddie	Art Unit 2875	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0026456	10-2001	Murakoshi et al.	362/516
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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